Notice of References Cited Application/Control No. 10/776,278 Applicant(s)/Patent Under Reexamination MARUYAMA ET AL. Examiner Binh X. Tran Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0084549	05-2004	Maruyama et al.	239/004
*	В	US-2004/0081759	04-2004	Maruyama et al.	427/256
*	С	US-2002/0025260	02-2002	Maruyama, Teruo	417/322
*	D	US-2002/0017238	02-2002	Shinozaki et al.	118/668
*	Е	US-6,063,339	05-2000	Tisone et al.	422/67
*	F	US-6,679,985	01-2004	Kim et al.	205/658
	G	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

	NON-I ATENT BOODMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.